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WHAT IS CLAIMED IS:

A method for fabricating a buried strap,
 comprising the steps of:

forming a dielectric collar along sidewalls of a trench, the trench formed in a substrate;

filling the trench with a conductive material;

recessing the conductive material in the trench to

expose a portion of the collar;

depositing a masking layer in the trench over the exposed portion of the collar;

removing a portion of the masking layer over one side of the collar;

etching a portion of the collar on the one side; and

forming a buried strap on the conductive material, which connects to the substrate on the one side.

- 2. The method as recited in claim 1, wherein the masking layer includes nitride.
- 3. The method as recited in claim 1, wherein the step of removing a portion of the masking layer includes patterning a cut mask for etching the masking layer.

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4. The method as recited in claim 1, wherein the step of removing a portion of the masking layer includes the steps of:

forming a polysilicon layer over the trench;

doping and oxidizing the polysilicon layer in

predetermined areas;

removing the polysilicon layer in other than the predetermined areas; and

etching the masking layer the in accordance with the predetermined areas.

- 5. The method as recited in claim 1, further comprising the step of forming isolation trenches in communication with the trench.
- 6. The method as recited in claim 5, further comprising the steps of:

oxidizing surfaces within the isolation trenches; lining the isolation trenches with a nitride layer;

filling the isolation trenches with a dielectric material.

7. The method as recited in claim 6, further comprising the steps of:

protecting portions of the nitride layer in communication with the trench during the step of removing a portion of the masking layer by employing surfaces oxidized in the step of oxidizing surfaces.

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8. The method as recited in claim 6, wherein the step of oxidizing surfaces includes forming an oxide between about 70 angstroms to about 90 angstroms in thickness.

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9. The method as recited in claim 1, wherein the step of forming a buried strap includes the steps of:

depositing a buried strap conductor in the trench; and

etching back the buried strap conductor.

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10. A method for fabricating a one-sided buried strap, comprising the steps of:

forming a dielectric collar along sidewalls of a trench, the trench formed in a substrate;

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filling the trench with a conductive material; etching isolation trenches in communication with the trench;

oxidizing surfaces within the isolation trenches; lining the isolation trenches with a nitride

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filling the isolation trenches with a dielectric material;

recessing the conductive material in the trench to expose a portion of the collar;

depositing a masking layer in the trench over the exposed portion of the collar;

removing a portion of the masking layer over one side of the collar;

etching a portion of the collar on the one side;

forming a buried strap on the one side.

- 11. The method as recited in claim 10, wherein the masking layer includes nitride.
- 12. The method as recited in claim 10, wherein the step of removing a portion of the masking layer includes patterning a cut mask for etching the masking layer.
- 13. The method as recited in claim 10, wherein the step of removing a portion of the masking layer includes the steps of:

forming a polysilicon layer over the trench;

doping and oxidizing the polysilicon layer in

predetermined areas;

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removing the polysilicon layer in other than the predetermined areas; and

etching the masking layer the in accordance with the predetermined areas.

14. The method as recited in claim 10, further comprising the steps of:

protecting portions of the nitride layer in communication with the trench during the step of removing a portion of the masking layer by employing surfaces oxidized in the step of oxidizing surfaces.

- 15. The method as recited in claim 10, wherein the step of oxidizing surfaces includes forming an oxide between about 70 angstroms to about 90 angstroms in thickness.
- 16. The method as recited in claim 10, wherein the step of forming a buried strap includes the steps of:

 depositing a buried strap conductor in the trench;
 and

etching back the buried strap conductor.

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